N-Channel Power MOSFET 600 V, 3.6 Ω

Features

- Low ON Resistance
- Low Gate Charge
- ESD Diode-Protected Gate
- 100% Avalanche Tested
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant



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V _{DSS}	R _{DS(on)} (MAX) @ 1.2 A
600 V	3.6 Ω

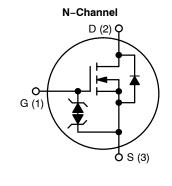
Rating	Symbol	NDF	NDD	Unit
Drain-to-Source Voltage	V _{DSS}	600		V
Continuous Drain Current $R_{\theta JC}$	Ι _D	3.1 (Note 1)	2.6	A
Continuous Drain Current $R_{\theta JC}$ T_A = 100°C	Ι _D	2.9 1.65 (Note 1)		A
Pulsed Drain Current, V_{GS} @ 10 V	I _{DM}	12	10	А
Power Dissipation $R_{\theta JC}$	PD	27	61	W
Gate-to-Source Voltage	V _{GS}	±30		V
Single Pulse Avalanche Energy, $I_D = 3.0 A$	E _{AS}	100		mJ
ESD (HBM) (JESD 22-A114)	V _{esd}	3000		V
RMS Isolation Voltage (t = 0.3 sec., R.H. \leq 30%, T _A = 25°C) (Figure 17)	V _{ISO}	4500		V
Peak Diode Recovery (Note 2)	dv/dt	4.5		V/ns
Continuous Source Current (Body Diode)	I _S	3.0		A
Maximum Temperature for Soldering Leads	ΤL	260		°C
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to 150		°C

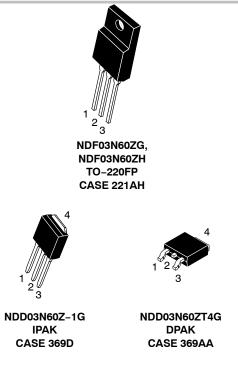
ABSOLUTE MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Limited by maximum junction temperature

2. I_{SD} = 3.0 Å, di/dt \leq 100 Å/µs, $V_{DD} \leq$ BV_{DSS} , T_J = +150°C





MARKING AND ORDERING INFORMATION

See detailed ordering and shipping information on page 7 of this data sheet.

THERMAL RESISTANCE

Parameter			Value	Unit
Junction-to-Case (Drain)	NDF03N60Z NDD03N60Z	$R_{\theta JC}$	4.7 2.0	°C/W
Junction-to-Ambient Steady State	(Note 3) NDF03N60Z (Note 4) NDD03N60Z (Note 3) NDD03N60Z-1	$R_{ heta JA}$	51 40 80	

3. Insertion mounted

4. Surface mounted on FR4 board using 1" sq. pad size, (Cu area = 1.127 in sq [2 oz] including traces).

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Characteristic	Test Conditions		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS						•	•
Drain-to-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 1 mA		BV _{DSS}	600			V
Breakdown Voltage Temperature Co- efficient	Reference to 25°C, I _D = 1 mA		$\Delta BV_{DSS}/\Delta T_{J}$		0.6		V/°C
Drain-to-Source Leakage Current	N 000 X X 0 X	25°C	I _{DSS}			1	μA
	$V_{DS} = 600 \text{ V}, V_{GS} = 0 \text{ V}$	150°C				50	
Gate-to-Source Forward Leakage	$V_{GS} = \pm 20 \text{ V}$	•	I _{GSS}			±10	μA
ON CHARACTERISTICS (Note 5)							
Static Drain-to-Source On-Resistance	V_{GS} = 10 V, I _D = 1.2 /	4	R _{DS(on)}		3.3	3.6	Ω
Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 50 \ \mu$	Ą	V _{GS(th)}	3.0	3.9	4.5	V
Forward Transconductance	V _{DS} = 15 V, I _D = 1.5 A		9 FS		2.0		S
DYNAMIC CHARACTERISTICS							
Input Capacitance (Note 6)	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz		C _{iss}	248	312	372	pF
Output Capacitance (Note 6)			C _{oss}	30	39	50	
Reverse Transfer Capacitance (Note 6)			C _{rss}	4	8	12	
Total Gate Charge (Note 6)	V _{DD} = 300 V, I _D = 3.0 A, V _{GS} = 10 V		Qg	6	12	18	nC
Gate-to-Source Charge (Note 6)			Q _{gs}	1.5	2.5	4	1
Gate-to-Drain ("Miller") Charge (Note 6)			Q _{gd}	3	6.1	9	
Plateau Voltage			V _{GP}		6.4		V
Gate Resistance			Rg		6.0		Ω
RESISTIVE SWITCHING CHARACTERI	STICS					•	
Turn-On Delay Time			t _{d(on)}		9		ns
Rise Time	V_{DD} = 300 V, I_D = 3.0 A, V_{GS} = 10 V, R_G = 5 Ω		t _r		8		-
Turn-Off Delay Time			t _{d(off)}		16		
Fall Time			t _f		10		
SOURCE-DRAIN DIODE CHARACTER	ISTICS (T _C = 25°C unless oth	erwise not	ed)		•	•	•
Diode Forward Voltage	I _S = 3.0 A, V _{GS} = 0 V		V _{SD}			1.6	V
Reverse Recovery Time	V _{GS} = 0 V, V _{DD} = 30 V	V	t _{rr}		265	1	ns
	$v_{GS} = 0 v, v_{DD} = 30 v$						

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

 $\begin{array}{l} V_{GS} = 0 \ V, \ V_{DD} = 30 \ V \\ I_S = 3.0 \ A, \ di/dt = 100 \ A/\mu s \end{array}$

Q_{rr}

0.9

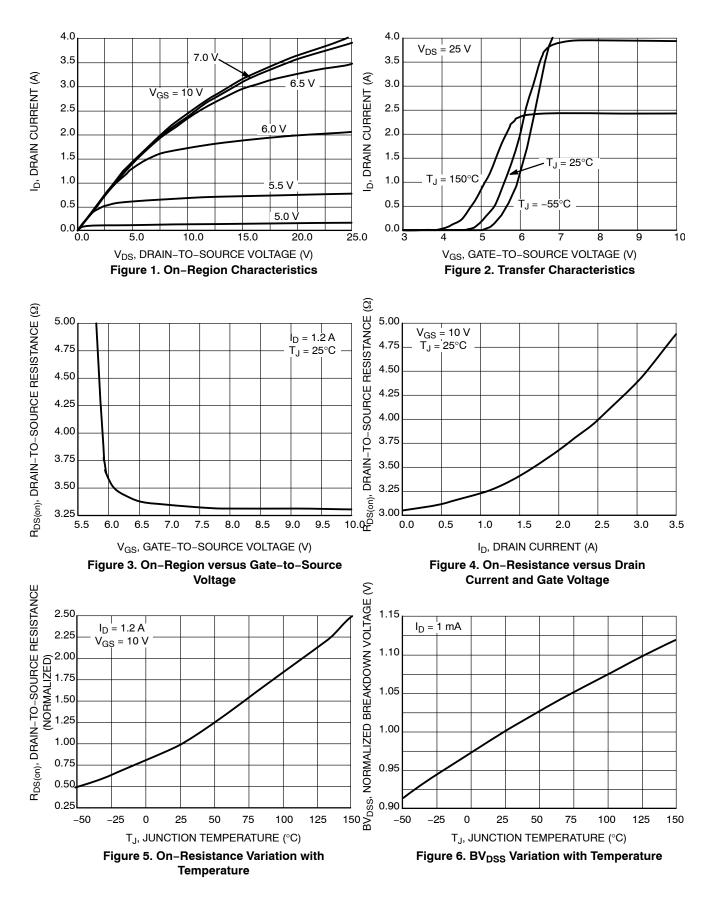
μC

5. Pulse Width \leq 380 µs, Duty Cycle \leq 2%.

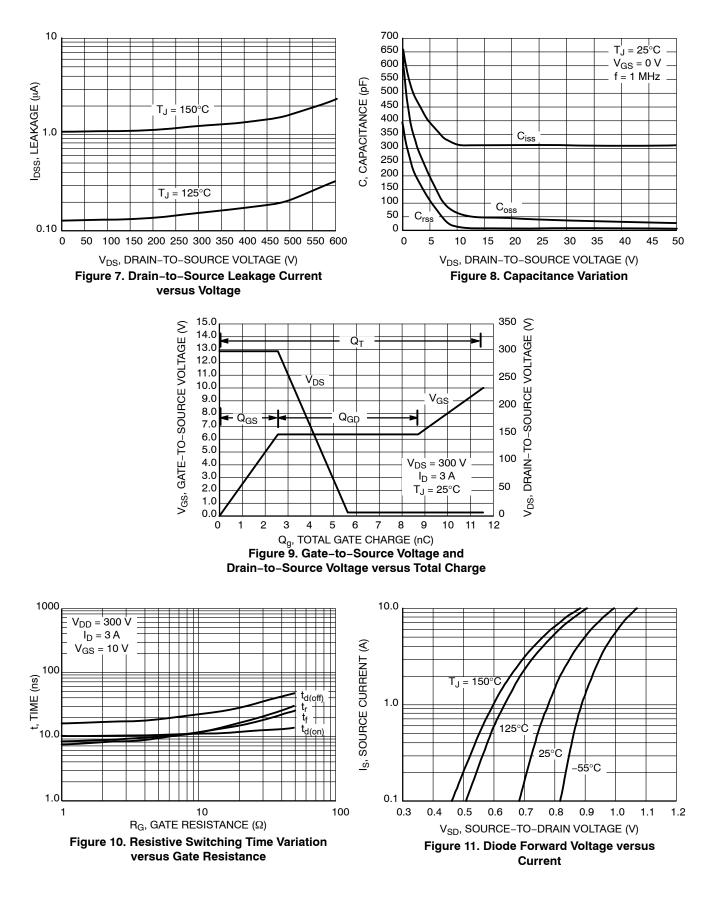
6. Guaranteed by design.

Reverse Recovery Charge

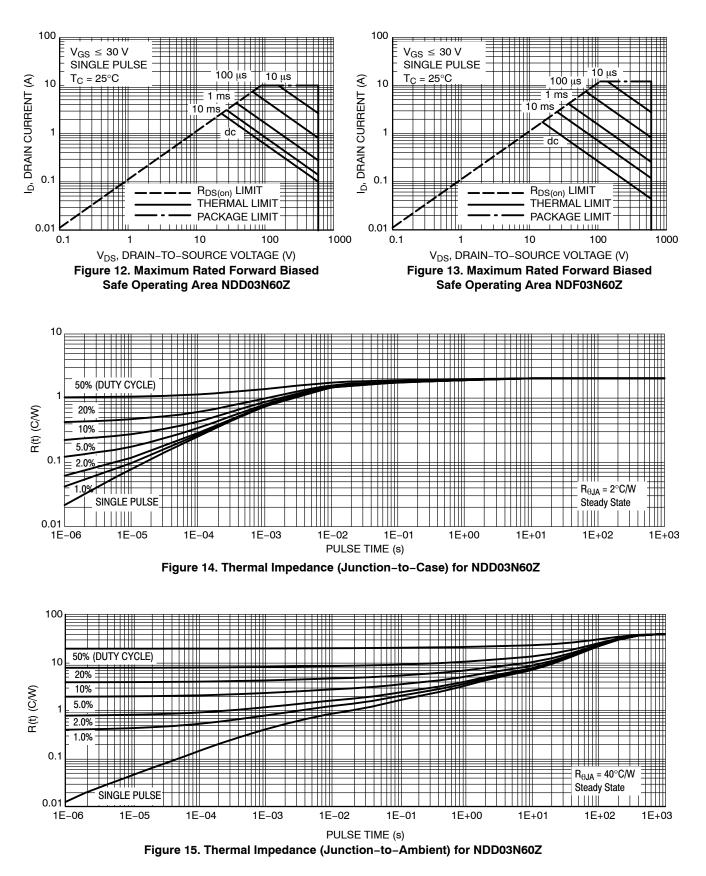
TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



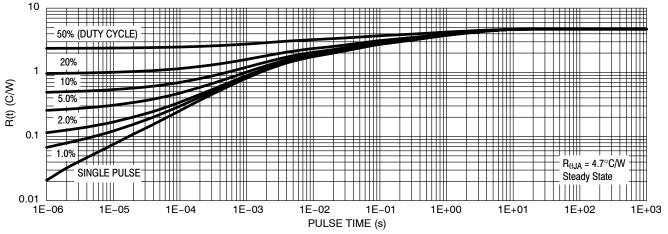


Figure 16. Thermal Impedance (Junction-to-Case) for NDF03N60Z

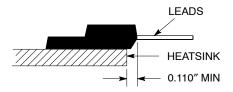
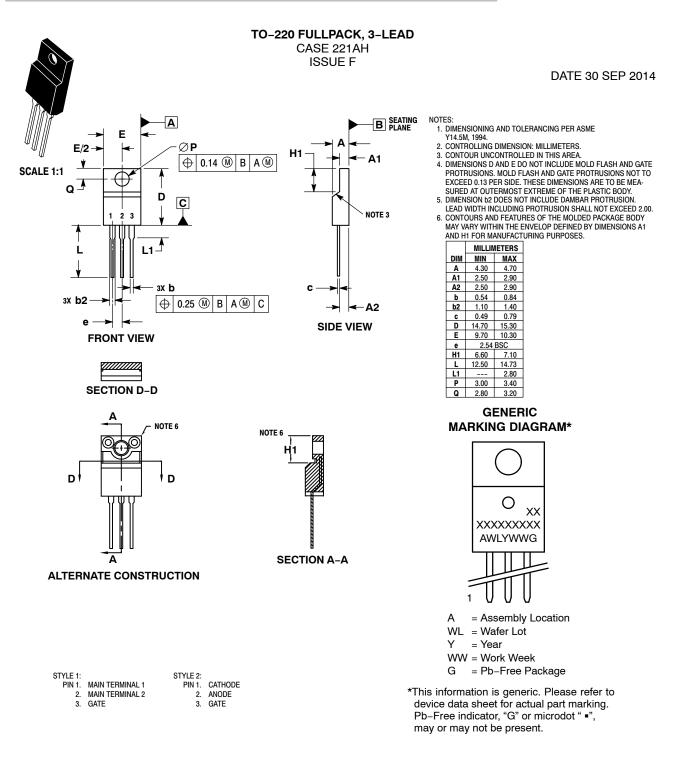


Figure 17. Isolation Test Diagram

Measurement made between leads and heatsink with all leads shorted together.

*For additional mounting information, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.





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IPAK CASE 369D-01 **ISSUE C**

DATE 15 DEC 2010

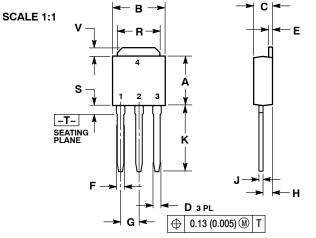
STYLE 1: PIN 1. BASE

2. COLLECTOR

3. EMITTER 4. COLLECTOR

STYLE 5: PIN 1. GATE 2. ANODE 3. CATHODE

4. ANODE



STYLE 2: PIN 1. GATE

STYLE 6: PIN 1. MT1 2. MT2 3. GATE

4. MT2

DRAIN
 SOURCE

4. DRAIN

STYLE 3: PIN 1. ANODE

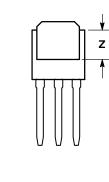
CATHODE
 ANODE

4. CATHODE

COLLECTOR

STYLE 7: PIN 1. GATE 2. COLLECTOR 3. EMITTER

4.



STYLE 4: PIN 1. CATHODE

ANODE
 GATE

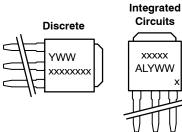
4. ANODE

	INCHES		MILLIMETER	
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090 BSC		2.29 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
Κ	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
V	0.035	0.050	0.89	1.27
Ζ	0.155		3.93	

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

NOTES:

MARKING DIAGRAMS

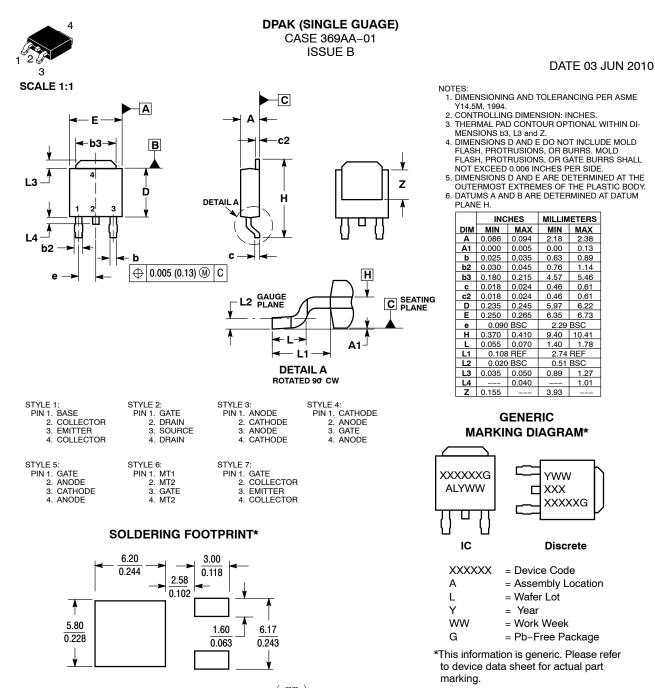


xxxxxxxx = Device Code А = Assembly Location IL = Wafer Lot Y = Year WW = Work Week

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SCALE 3:1 $\left(\frac{\text{mm}}{\text{inches}}\right)$

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